## NOTES:

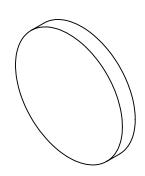
- 1. SUBSTRATE: UV FUSED SILICA
- 2. SURFACE S2 TO BE PARALLEL WITH SURFACE S1 TO WITHIN 5 arcsec
- 3. COATING (APPLY ACROSS COATING APERTURE)
  - \$1: HARD DIELECTRIC SPUTTERED
    T(avg): ≥91% FROM 1220 1650nm @ 0° AOI
    T(avg): ≤0.01% FROM 200 1180nm @ 0° AOI
    T(abs): =50% FOR 1200±12nm @ 0° AOI

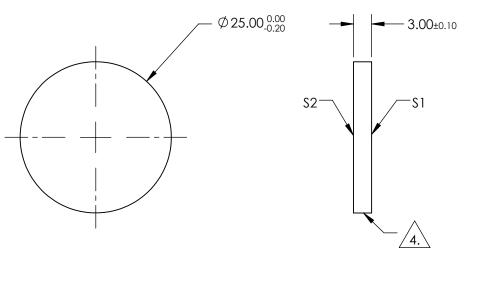
S2:SINGLE LAYER MgF2

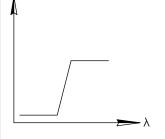
## 4. FINE GRIND SURFACE

- 5. POWER, IRREGULARITY, AND SURFACE QUALITY SPECIFICATIONS APPLY ACROSS CLEAR APERTURE
- 6. TRANSMITTED WAVEFRONT DISTORTION, RMS: ≤λ/4 @ 633nm (prior to coating)
- 7. ROHS COMPLIANT









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## SPECIFICATIONS SUBJECT TO CHANGE WITHOUT NOTICE DIMENSIONS ARE FOR REFERENCE ONLY

LONGPASS FILTER			_		Edmund Optics <sup>®</sup>
	S1	S2			
SHAPE	PLANO	PLANO			Ø25mm, 1200nm, HIGH PERFORMANCE
SURFACE QUALITY	60-40	60-40	THIRD ANGLE	TITLE	LONGPASS FILTER
CLEAR APERTURE	>80%	>80%			
BEVEL	PROTECTIVE AS NEEDED	PROTECTIVE AS NEEDED	ALL DIMS IN mm	DWG NO	89662 SHEE 1 OF